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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,091	OHNO ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	108.24	3/1/2007	JG
	109.3		
	110.3		
	137.15		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
430	108.24	3/1/2007	JG
	109.3		
	110.3		
430/1	430/137.15		

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